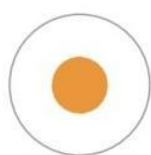
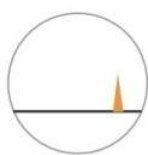


## SPD500 series Si-APD Detector module

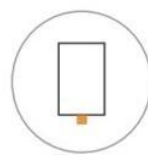
SPD500 is an ultra sensitive photodetector based on Si APD. The detection band covers 200-1060 nm and can operate in linear mode and Geiger mode. Gain exceeds 60 dB in Geiger mode. The SPD500's unique high-performance active suppression circuit enables continuous single photon detection and can load detection gates of any width and period. This circuit achieves avalanche suppression greater than 20 dB, thereby maximizing the performance of SPD500. The detection efficiency in the 700 nm band exceeds 60%, with a dark count of 200-500 CPS and the dead time of less than 50 ns.



Single photon sensitivity



Low Dark Count



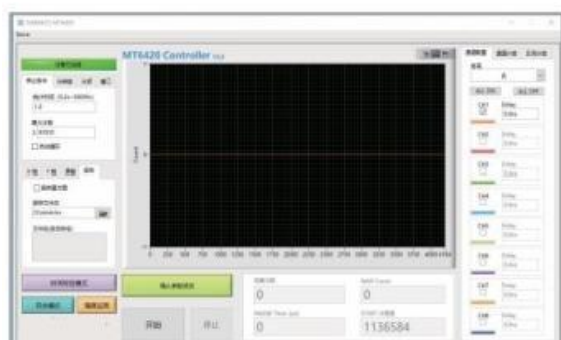
High reliability

| Parameter                                                            | Mminimum value | Typical values          | Maximum value   | Unit |
|----------------------------------------------------------------------|----------------|-------------------------|-----------------|------|
| Supply voltage                                                       |                | 12                      |                 | V    |
| Supply current                                                       |                | 0.5                     |                 | A    |
| Spectral Range                                                       | 200            |                         | 1060            | nm   |
| Detection efficiency<br>@200 nm<br>@700 nm<br>@850 nm<br>@1060 nm    |                | 2<br>/<br>65<br>45<br>3 |                 | %    |
| Dark count                                                           | 200            |                         | 500             | cps  |
| Dead time                                                            |                | 50                      |                 | ns   |
| Afterpulse                                                           | 3              | 5                       | 8               | %    |
| Saturation count rate*2                                              |                | 10                      | 15              | Mcps |
| Photosensitive area                                                  |                | 500                     |                 | μm   |
| APD Cooling temperature                                              |                | -20                     |                 | °C   |
| Operating temperature                                                | -15            |                         | 50              | °C   |
| Output signal level standard                                         |                | LVTTL                   |                 |      |
| Output signal pulse width                                            | 5              | 30                      |                 | ns   |
| Gate pulse input level<br>Disable = LVTTL low<br>Enable = LVTTL high | 0<br>/<br>2    |                         | 0.4<br>/<br>3.3 | v    |
| Gate pulse frequency                                                 |                |                         | 5000            | kHz  |
| Power consumption                                                    |                | 5                       | 8               | W    |

2.该值为默认设置下的结果，改变输出脉宽或死时间会改变饱和计数率。

# SPD500 series Si-APD Detector module

## Software interface



Main program interface



Complies with counting function

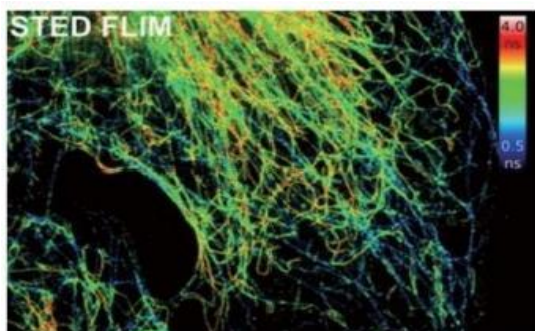


Time tag function

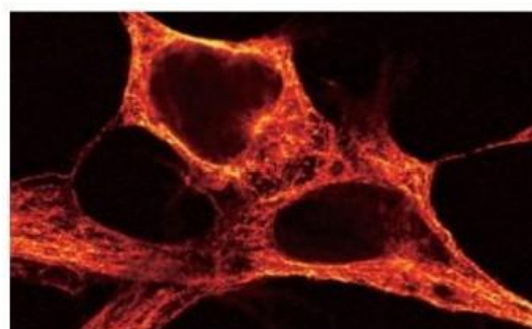


Intensity observation function

## Application Cases



STED microscopy imaging



Instrument scanning HEK cell map



Quantum communication



Fluorescence lifetime measurement